FORM PTO 1449 (*modified*)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

OIPE JC1200 FEB 14 2002 PATENT & TRADEMARK OFFICE

ATTY DOCKET NO.	APPLICATION NO.
00862.003016	09/374,580

APPLICANT: TATSUO FURUKAWA ET AL.

FILING DATE	GROUP
August 16, 1999	2854

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
CH		5,851,075	12/22/98	Imai	400	120	
CH		5,886,713	03/23/99	Okada et al.	347	14	
CH		5,838,341	11/17/98	Hiwada	347	14	
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
CH	JP	09 131879	05/20/97	Japan			x
CH	EP	0 694 391	01/31/96	EPO			Orig. Engl.
CH	JP	08 252926	10/01/96	Japan			x
CH	EP	0 631 870	01/04/95	EPO			Orig. Engl.
CH	JP	08 244231	09/24/96	Japan			x
	x	Couterpart US patents enclosed					

EXAMINER: NOLAN DATE CONSIDERED: 4-19-02

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Form #62
NY MAIN 238097

FORM PTO 1449 (*modified*)

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OIPE JC1 FEB 14 2002 PATENT & TRADEMARK OFFICE

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
CH	EP	0 661 162	07/05/95	EPO			Eng. Orig.
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OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

		Patent Abstracts of Japan, vol. 1996, no. 06, 6/28/96 (JP 08- 034137, 2/6/96)
	x	Counterpart US patent enclosed

EXAMINER	NOLAN	DATE CONSIDERED	4-19-02

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